Bronze Tech

**RoHS** COMPLIANT

Dual-Channel Isolated Gate Driver

# BTD25350x Dual-Channel Isolated Gate Driver

### 1.Features

- Isolation voltage up to 5000Vrms
- Peak output current up to 10A
- Propagation delay 60ns
- Maximum switching frequency 1MHz
- Primary-side supply 3~5V
- Secondary-side supply up to 33V
- Primary-side and secondary-side power supply undervoltage lockout (UVLO)
- Compatible with 3.3V, 5V input
- Feature Options: Miller Clamp Options (BTD25350MM)
  Split Outputs (BTD25350MS)
  UVLO referenced to secondary side GNDx (BTD25350ME)
- SOW-18 with 8.5mm creepage
- Operating Temperature -40~125°C

## **3.Description**

BTD25350x is a family of dual-channel, isolated gate driver with peak output current up to 10A, available in SOW-18 (wide-body) package and supports isolation voltages up to 5000Vrms. They can be used to drive IGBTs and Si/SiC MOSFETs. BTD25350x family offers 3 Feature Options:

BTD25350MM provides Miller clamp function to prevent false turn-on caused by Miller current.

BTD25350MS provides a split output with rise and fall time individually configurable.

BTD25350ME provides UVLO in positive power supply of secondary-side to ensure that power devices get sufficient gate turn-on voltage.

**SOW-18** 



- Motor drives
- EV chargers
- Telecommunication power supplies
- EV power supplies
- UPS
- String solar inverters

## **4.**Functional Block Diagram









#### BTD25350ME

Preliminary Datasheet Rev.0.1

## **Bronze Tech** —

Dual-Channel Isolated Gate Driver

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## **5.Product Information**

Part No.	Pin Configuration	Isolation Voltage	UVLO Threshold	Operating Temperature	Package	Package Material	Quantity	Marking		
BTD25350MMBWR			8V					BTD25350MMB		
BTD25350MMCWR	disable function, Miller-clamp dead time configuration and disable function, split output	-	-		11V					BTD25350MMC
BTD25350MSBWR		5000Vrms	8V	-40~125°C S	SOW-18	Tape &	1000pcs	BTD25350MSB		
BTD25350MSCWR				SUUUVIIIIS	11V	-40~125 C	2011-18	Reel	/Reel	BTD25350MSB
BTD25350MEBWR	dead time configuration and		8V					BTD25350MEB		
BTD25350MECWR	disable function, UVLO with reference to GNDx		11V					BTD25350MEC		

## 6.Pin Configuration and Functions

#### 6.1 BTD25350MMx

NO.	NAME	TYPE <sup>(1)</sup>	DESCRIPTION	PACKAGE
1	NC	-	No internal connection	
2	IN1	I	Signal input channel 1	
3	IN2	I	Signal input channel 2	
4	VCC	Р	Primary-side supply voltage	
5	GND	G	Primary side ground	
6	DIS	I	Disables both driver outputs if asserted high, enables if set low or left open	NC 1 0 18 VEE1 IN1 2 17 CLAMP1
7	DT	l	Programmable dead time function	IN2 3 16 OUT1
8	NC	-	No internal connection	VCC 4 15 VDD1
9	VCC	Р	Primary-side supply voltage	GND 5 BTD25350MMx DIS 6
10	NC	-	No internal connection	DT 7 14 VEE2
11	VDD2	Р	Channel 2 positive output supply rail	NC 8 13 CLAMP2
12	OUT2	0	Channel 2 gate-drive output	VCC     9     12     OUT2       NC     10     11     VDD2
13	CLAMP2	I	Channel 2 Miller-clamp input	
14	VEE2	Р	Channel 2 negative output supply rail	
15	VDD1	Р	Channel 1 positive output supply rail	
16	OUT1	0	Channel 1 gate-drive output	
17	CLAMP1		Channel 1 Miller-clamp input	
18	VEE1	Р	Channel 1 negative output supply rail	
(1) P=Powe	er, G=Ground	l, I=Input, O=Ou	tput	



#### 6.2 BTD25350MSx

NO.	NAME	TYPE <sup>(1)</sup>	DESCRIPTION	PACKAGE
1	NC	-	No internal connection	
2	IN1	I	Signal input channel 1	
3	IN2	I	Signal input channel 2	
4	VCC	Р	Primary-side supply voltage	
5	GND	G	Primary-side ground reference	
6	DIS	I	Disables both driver outputs if asserted high, enables if set low or left open	NC 1 0 18 VEE1 IN1 2 17 OUTL1
7	DT		Programmable dead time function	IN2 3 16 OUTH1
8	NC	-	No internal connection	VCC 4 15 VDD1
9	VCC	Р	Primary-side supply voltage	BTD25350MSx DIS6
10	NC	-	No internal connection	DT 7 14 VEE2
11	VDD2	Р	Channel 2 positive output supply rail	NC 8 13 OUTL2 VCC 9 12 OUTH2
12	OUTH2	0	Channel 2 gate-drive pullup output	NC 10 11 VDD2
13	OUTL2	0	Channel 2 gate-drive pulldown output	
14	VEE2	Р	Channel 2 negative output supply rail	
15	VDD1	Р	Channel 1 positive output supply rail	
16	OUTH1	0	Channel 1 gate-drive pullup output	
17	OUTL1	0	Channel 1 gate-drive pulldown output	
18	VEE1	Р	Channel 1 negative output supply rail	
(1) P=Pow	er, G=Ground	d, I=Input, O=Ou	tput	



#### 6.2 BTD25350MEx

NO.	NAME	TYPE <sup>(1)</sup>	DESCRIPTION	PACKAGE
1	NC	-	No internal connection	
2	IN1	l	Signal input channel 1	
3	IN2	ļ	Signal input channel 2	
4	VCC	Р	Primary-side supply voltage	
5	GND	G	Primary-side ground reference	
6	DIS	I	Disables both driver outputs if asserted high, enables if set low or left open	NC 1 1 18 VEE1
7	DT	l	Programmable dead time function	IN1 2 17 GND1 IN2 3 16 OUT1
8	NC	-	No internal connection	VCC 4 15 VDD1
9	VCC	Р	Primary-side supply voltage	GND 5 BTD25350MEx
10	NC	-	No internal connection	DIS 6
11	VDD2	Р	Channel 2 positive output supply rail	DT 7 14 VEE2
12	OUT2	0	Channel 2 gate-drive output	NC     8     13     GND2       VCC     9     12     OUT2
13	GND2	G	Channel 2 gate-drive common	VCC     9     12     OUT2       NC     10     11     VDD2
14	VEE2	Р	Channel 2 negative output supply rail	
15	VDD1	Р	Channel 1 positive output supply rail	
16	OUT1	0	Channel 1 gate-drive output	
17	GND1	G	Channel 1 gate-drive common	
18	VEE1	Р	Channel 1 negative output supply rail	
(1) P=Powe	er, G=Ground	d, I=Input, O=Ou	tput	

## 7. Specification Parameters

## 7.1 Absolute Limits

PARAMETER	TEST CONDITIONS	MIN	MAX	UNIT
Input bias pin supply voltage	VCC-GND	GND-0.3	6.5	
Driver bias supply	VDDx-VEEx	0	35	
Bipolar supply voltage for E version	VEEx-GNDx	-17.5	0.3	V
Output signal voltage	OUTx, OUTHx, OUTLx, CLAMPx	VEEx-0.3	VDDx+0.3	
Input signal voltage	INx, DT, DIS to GND	GND-5V	VCC+0.3	
Operating Junction Temperature, TJ	-	-40	150	°C
Storage Temperature, Ts	-	-65	150	
	Human body model (HBM)	±3	000	V
ESD Voltage	Charged device model (CDM)	) ±1500		

## 7.2 Recommended Operating Conditions

SYMBOL	PARAMETER	MIN	MAX	UNIT	
Vcc	Input supply voltage (VCC-GND)	3	5	V	
N		BTD25350xBx	9.5	33	V
V <sub>DDx</sub>	Total supply voltage output side (VDDx-VEEx)	13.2	33	V	
VEEx	Bipolar supply voltage for E version (VEEx–GNDx)		-16	0	V
TA	Ambient temperature		-40	125	°C

### **7.3 Electrical Characteristics**

 $T_{A} {=} {-} 40 {\sim} 125 {^\circ}C$  ,  $V_{CC} {=} 3.3$  or 5V,  $V_{DDx} {=} 15V$ ,  $C_{L}{^{(1)}} {=} 100 pF.$ 

Output pin: current towards outside of the chip is positive direction; Input pin: current towards inside of the chip is positive direction.

SYMBOL	PARAMETER	TEST CONDITIONS	MIN	ТҮР	MAX	UNIT					
	SUPPLY CURRENTS										
lvccq	Primary side input supply quiescent current	V <sub>DDx</sub> =15V, V <sub>IN1</sub> =V <sub>IN2</sub> =0V	-	1.5	2						
Ivccq-st	Primary side input supply current	V <sub>IN1</sub> =V <sub>IN2</sub> =5V, f=500kHz, C <sub>L</sub> =100pF, D=50%	-	2	-	mA					
	PRIMARY SIDE UN	DERVOLTAGE LOCKOUT	•								
Von_vcc	Positive-going UVLO threshold voltage	-	-	2.6	-						
Voff_vcc	Negative-going UVLO threshold voltage	-	-	2.5	-	V					
VUV_HYS_VCC	Threshold hysteresis	-	-	0.1	-						
	SECONDARY SIDE U	NDERVOLTAGE LOCKOUT									
Von_vddx	Positive-going UVLO threshold voltage VDDx-VEEx		-	12	13						
Voff_vddx	Negative-going UVLO threshold voltage VDDx-VEEx	BTD25350xxC	10.3	11	-						
V <sub>UV_HYSx</sub>	Threshold hysteresis		-	1	-						
V <sub>ON_VDDx</sub>	Positive-going UVLO threshold voltage VDDx-VEEx		-	8.7	9.4						
V <sub>OFF_VDDx</sub>	Negative-going UVLO threshold voltage VDDx-VEEx	BTD25350xxB	7.3	8	-	]					
V <sub>UV_HYSx</sub>	Threshold hysteresis	]	-	0.7	-						



(Continued)

		INPUT	CHARACTERISTICS				
VIH	Positive-going input threshold volt	age (INx, DIS)	Vcc=5V	-	2.4	-	
VIL	Negative-going input threshold vol	tage (INx, DIS)	V <sub>cc</sub> =5V	-	1.4	-	V
VI_HYS	Input hysteresis voltage	-		-	1	-	
IIH	High-level input leakage at IN+		INx=V <sub>cc</sub>	-	650	-	
l <sub>IL</sub>	Low-level input leakage at IN-		INx=GND	-	-	5	μA
		OUTPUT	CHARACTERISTICS				
Іон	Peak output source current		-	-	10	-	_
lol	Peak output sink current		-	-	10	-	A
Vон	Output voltage at high state (OUTx	, OUTHx)	l <sub>out</sub> =20mA	-	VDDx-0.06	-	V
Vol	Output voltage at low state (OUTx,	OUTLx)	lout=-20mA	VEEx+0.005	VEEx+0.007	-	
		MILLER CL	AMP BTD25350MMxx				
VCLAMP	Low-level clamp voltage		I <sub>CLAMP</sub> =-20mA	-	7	10	mV
I <sub>CLAMP</sub>	Low-level clamp current		V <sub>CLAMP</sub> =VEEx+15V	-	10	-	Α
VCLAMP_TH	Clamping threshold voltage		-	-	2.2	-	V
	•	SHORT-	CIRCUIT CLAMPING				•
	Clamping voltage (VOUTx-VDDx or VOUTHx-VDDx)		INx=HIGH, t <sub>clamp</sub> =10µs, І <sub>оитнх</sub> or І <sub>оитх</sub> =-500mA	-	1	1.3	
V <sub>CLP-OUT</sub>	Clamping voltage (VEEx-VOUTx or VEEx-VOUTLx or VE	Ex-CLAMPx)	INx=LOW, t <sub>CLAMP</sub> =10μs, I <sub>CLAMPx</sub> or I <sub>OUTLx</sub> =500mA	-	1.5	-	V
			INx=LOW, I <sub>CLAMPx</sub> or I <sub>OUTLx</sub> =20mA	-	0.9	1	
		ACTIVE PU	JLL-DOWN FUNCTION				
Voutsd	Active pulldown voltage on OUTLx CLAMPx, OUTx	,	I₀u⊤=-1A (sinking into OUTx, OUTLx or CLAMPx pin), VDDx=left open	-	2.3	2.6	V
		SWITCH	HING PARAMETERS				
t <sub>PLH</sub>	Propagation delay from INx to OUT	x rising edges	CL=100pF	-	60	75	
t <sub>PHL</sub>	Propagation delay from INx to OUT	x falling edges	C <sub>L</sub> =100pF	-	60	75	1
tr	Output rise time		C∟=1nF	-	10	26	
t <sub>f</sub>	Output fall time		CL=1nF	-	10	26	ns
t <sub>PWD</sub>	Pulse width distortion  tphl-tplh		C∟=100pF	-	1	20	1
t <sub>sk</sub>	Part-to-part skew		C∟=100pF	-	1	25	1
t <sub>UVLO1-rec</sub>	Undervoltage lockout recovery	Input side	VCC	-	40	-	
t <sub>UVLO2-rec</sub>	delay time	Output side	VDDx	-	50	-	μs
СМТІ	Common-mode transient immunit	V	INx fixed to GND or VCC, V <sub>CM</sub> =1500V	100	150	-	kV/μs



### **7.4 SAFETY PARAMETERS**

Symbol	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
CLR	External clearance	-	8.5	-	-	1	
CPG	External creepage	-	8.5	-	-	mm	
DTI	Distance through the insulation	-	17	-	-	μm	
CTI	Comparative tracking index	DIN EN 60112	600	-	-	V	
	Overvoltage category per	Voltage rating ≤ 600Vrms	I-IV	-	-		
-	IEC 60664-1	Voltage rating ≤ 1000Vrms	-	-	-	] -	
	·	DIN V VDE 0884-11					
VIORM	Maximum repetitive peak isolation voltage	AC voltage (bipolar)	2121	-	-	V <sub>РК</sub>	
VIOWM	Maximum isolation working voltage	AC voltage (sine wave); time dependent dielectric breakdown (TDDB)	1500	-	-	Vrms	
		DC voltage	2121	-	-	V <sub>DC</sub>	
VIOTM	Maximum transient isolation voltage	V <sub>TEST</sub> =V <sub>IOTM</sub> , t=60s (qualification) V <sub>TEST</sub> =1.2×V <sub>IOTM</sub> , t=1s (100% production)	7000	-	-		
V <sub>IOSM</sub>	Maximum surge isolation voltage	IEC 62368-1, 1.2/50µs waveform, V <sub>TEST</sub> =1.6×V <sub>IOSM</sub> =12800V <sub>PK</sub> (qualification)	8000	-	-	- V <sub>PK</sub>	
		Method a, After Input/Output safety test subgroup 2/3. $V_{INI}$ = $V_{IOTM}$ , $t_{INI}$ =60s; $V_{pd(m)}$ =1.2× $V_{IORM}$ =2545 $V_{PK}$ , tm=10s	-	-	5		
$Q_{\text{pd}}$	Apparent charge	Apparent charge   Method a, After environmental tests subgroup 1.     VINI=VIOTM, tINI=60s;   -     Vpd(m)=1.6×VIORM=3394VPK, tm=10s   -				5	pC
		$\begin{array}{l} \mbox{Method b1; At routine test (100\% production)} \\ \mbox{and preconditioning (type test)} \\ \mbox{V}_{\text{INI}}=1.2\times\mbox{V}_{\text{IOTM}}, t_{\text{INI}}=1\text{s}; \\ \mbox{V}_{\text{pd}(m)}=1.875\times\mbox{V}_{\text{IORM}}=3977\mbox{V}_{\text{PK}}, tm=1\text{s} \end{array}$	-	-	5	-	
CIO	Barrier capacitance, input to output	V <sub>I0</sub> =0.4Vrms, f=1MHz, sine wave	-	1.2	-	pF	
		Test voltage of 500V, T <sub>A</sub> =25°C	1012	-	-		
Rio	Isolation resistance, input to output	Test voltage of 500V, 100°C≤ T <sub>A</sub> ≤125°C	1011	-	-	Ω	
		Test voltage of 500V, T <sub>A</sub> =150°C	10 <sup>9</sup>	-	-	]	
	Pollution degree	-	-	2	-	-	
	Climatic category	-		40/125/21			
		UL1577					
V <sub>ISO</sub>	Withstand isolation voltage	$V_{TEST}=V_{ISO}$ , t=60 sec(qualification); $V_{TEST}=1.2 \times V_{ISO}=6000Vrms$ , t=1 sec(100% production)	5000	-	-	Vrms	



## 8.Parameter Testing

### 8.1 Propagation Delay

The method for measuring the rise time  $(t_r)$  and fall time  $(t_f)$  see Figure 1.



#### 8.2 CMTI



Figure 2. CMTI Test Circuit for BTD25350MMx



Figure 4. CMTI Test Circuit for BTD25350MEx



Figure 3. CMTI Test Circuit for BTD25350MSx



## **9.Function Description**

#### 9.1 Isolation Design Description

The isolation inside the BTD25350x series is implemented with high voltage SiO<sub>2</sub> based capacitors. There is a capacitor on each of the primary-side and secondary-side to enhance insulation. The signal across the isolation has an on-off keying (OOK) modulation scheme to transmit the digital data. The primary-side transmits a high-frequency carrier to represent one digital state, and sends no signal to represent the other digital state. On the secondary side, the receiver demodulates the signal and produces output for control. One can also add special anti-jamming circuit on the primary /secondary sides to enhance the CMTI performance and minimize the radiate emissions (see Figure 5, 6).



Figure 5. Conceptual Block Diagram of a Capacitive Data Channel



Figure 6. OOK Based Modulation Scheme

#### 9.2 Input Stage Characteristics

With input pins and secondary side completely isolated, BTD25350x is designed to be CMOS-compatible. It supports 3.3V, 5V level input, making the chip easy to accept control of multiple logic levels. The input pin has Schmitt-trigger characteristic to enhance the immunity against disturbances. The INx and DIS input port has a  $200k\Omega$  pull-down resistor to force it grounding, which can ensure that the output ports are in OFF state when input ports are left open. However, in order to configure the initial power-on state of the driver IC, Bronze Technologies still recommends adding externally an appropriate pull-up or pull-down resistor to the input.

#### 9.3 Primary Side Device Function

#### 9.3.1 Disable

When the DIS pin is set to a high level, both outputs can be shut down at the same time. The device operates normally when the DIS pin is grounded or left open. The response time of the disable function is within 20ns. The disable function is activated or deactivated according to the setting only when the VCC is kept above the undervoltage turn-on threshold.

BTD25350x

If the DIS pin is not used, it is recommended to connect it to the ground. If connecting DIS pin to a microcontroller with distance, it is recommended to bypass the DIS pin with a low ESR/ESL capacitor of approximately 1nF for better noise immunity.

#### 9.3.2 Dead Time Setting

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DT pin sets the dead time. It is used to set the dead time between channel 1 and channel 2 to prevent them from shootthrough. The steady-state voltage of DT pin is 0.8V, and the current value of the pin is measured for corresponding dead time. The dead time is calculated as  $T_{DT}=10 \times R_{DT}$ . The unit of  $t_{DT}$  is ns and the unit of  $R_{DT}$  is  $k\Omega$ . To ensure that the pin signal is not interfered, it is recommended to place a 2.2nF capacitor near the IC between DT pin and GND, and it is not recommended to left DT pin open.Pull DT up to VCC enables independent operation of two channels, no dead time is inserted, two outputs are allowed to be both high.



#### 9.4 Output Booster Characteristics

The BTD25350x has a rail-to-rail push stage output. The pull-up structure of the output stage consists of a P-channel MOSFET and an N-channel MOSFET connected in parallel. At turn-on, N-channel MOSFET provides high current driving capability. P-channel MOSFET provides a small steady-state conduction voltage drop during steady conduction. The pull-down structure is implemented using an N-channel MOSFET. A  $1M\Omega$  resistor is connected in parallel between the drain and gate of the MOSFET to effectively clamp the gate voltage of the power device in the event of a loss of power on the chip to prevent the occurrence of partial turn-on. However, in order to ensure reliable shutdown of the power device, Bronze Technologies recommends that appropriate pull-down resistor should be added to the gate.

It is recommended to connect Schottky clamping diode on the gate output for the positive supply VDDx and negative supply VEEx, in order to prevent gate transient over voltage.



Figure 8. Output Stage



#### 9.5 Protection Functions

#### 9.5.1 Undervoltage Lockout

The BTD25350x has undervoltage lockout (UVLO) function on the primary-side power supply and the secondary-side total supply voltage to prevent the gate drive voltage from being insufficient. When the supply voltage drops below UVLO threshold, the IC turns off the output to protect the power devices. When the supply voltage reaches the positive-going negative-going threshold, the IC resumes the output. To prevent repeated action near the UVLO threshold, the IC is configured with hysteresis. In order to avoid the uncertainty of the output state after power-on, the IC first enters a UVLO state after power-on, keeps the output off until the supply voltage is established and then starts normal operation (see Figure 9).



#### **Figure 9. UVLO Functions**

#### 9.5.2 Miller Clamp

The active Miller clamp function is used to prevent the power devices from false turn-on of the power switched cause by the Miller current. A low impedance path is added between the gate terminal and ground (VEEx) to sink the Miller current. The Miller clamp function clamps the gate voltage of the power device to VEEx with the output is in the off state.

#### 9.5.3 Short-Circuit Clamping

The short-circuit clamping function is used to clamp voltages at the driver output and pull the active Miller clamp pins slightly higher than the VDDx voltage during short-circuit conditions. The short-circuit clamping function helps protect the IGBT or MOSFET gate from overvoltage breakdown or degradation. The short-circuit clamping function is implemented by adding a diode connection between the dedicated pins and the VDDx pin inside the driver. The internal diodes can conduct up to 500-mA current for a duration of 10 µs and a continuous current of 20 mA. Use external Schottky diodes to improve current conduction capability as needed.

#### 9.5.4 Active Pull-Down

The active pull-down function is used to pull the IGBT or MOSFET gate to the low state when no power is connected to the VDDx. This feature prevents false IGBT and MOSFET turn-on on the OUTx, OUTLx and CLAMPx pins by clamping the output to approximately 2V.



#### 9.6 ESD Structure

The figure below shows the ESD-protected diode configuration of the input and output pins.



Figure 10. ESD Structure Diagram

## 9.7 Input and Output Logic Table

#### BTD25350MM 和 BTD25350ME

INF	TUY	DIS	OUTPUT		DESCRIPTION
IN1	IN2	015	OUT1	OUT2	DESCRIPTION
L	L	L or left open	L	L	
L	Н	L or left open	L	Н	If dead time function is used, output switching occurs after the dead time ended.See Programmable Dead Time (DT) pin
Н	L	L or left open	Н	L	
Н	Н	L or left open	L	L	Dead time stay open or programmed with $R_{\mbox{\tiny DT}}$
Н	Н	L or left open	Н	Н	Dead time pin pulled to VCC
Left open	Left open	L or left open	L	L	-
Х	Х	Н	L	L	-

#### BTD25350MS

INF	TUY	DIS		OUT	PUT		DESCRIPTION
IN1	IN2	015	OUTH1	OUTL1	OUTH2	OUTL2	DESCRIPTION
L	L	L or left open	Hi-Z	L	Hi-Z	L	If dead time function is used, output switching
L	Н	L or left open	Hi-Z	L	Н	Hi-Z	occurs after the dead time ended.See Program-
Н	L	L or left open	Н	Hi-Z	Hi-Z	L	mable Dead Time (DT) pin
Н	Н	L or left open	Hi-Z	L	Hi-Z	L	Dead time stay open or programmed with $R_{\mbox{\tiny DT}}$
Н	Н	L or left open	Н	Hi-Z	Н	Hi-Z	Dead time pin pulled to VCC
Left open	Left open	L or left open	Hi-Z	L	Hi-Z	L	-
Х	Х	Н	Hi-Z	L	Hi-Z	L	-



## **10.Applications**

The following sections introduce the basic typical application of Bronze Technologies driver ICs, which is for reference only. In practical application, users need to verify and test its applicability according to their own design requirements to confirm the system functions.

### **10.1 Typical Applications**

Bronze Technologies recommends that customers add a RC filter with a small time constant at the input port to filter out high-frequency interference without adding a large delay. It is recommended that the resistance value should be between 0 and  $100\Omega$  and the capacitance should be less than 1000 pF. When setting this parameter, the influence between high frequency interference and delay needs to be taken into account.

To ensure the supply stability, Bronze Technologies recommends to add appropriate blocking capacitor between the power supply and ground. It is recommended to parallel a  $1\mu$ F+  $0.1\mu$ F capacitor between VCC-GND, and a  $10\mu$ F+  $0.22\mu$ F capacitor between VDDx-VEEx (Figure 11,12,13).



Figure 11. BTD25350MMx Application Diagram



Figure 12. BTD25350MSx Application Diagram

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**Dual-Channel Isolated Gate Driver** 



Figure 13. BTD25350MEx Application Diagram

#### **10.2 Recommended Design of Secondary Side Supply**

In order to avoid partial turn-on of the gate of the power device due to interference, it is recommended that customers add a negative supply when designing the driving output. It is recommended to use the following two methods to generate the negative supply: use a regulator to generate stable negative voltage, or use both positive and negative supplies.



Figure 14. Voltage Regulator Design



## 11.Packaging and Packing Information

## 11.1 Package Identifier

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Note: 1) Legend unit: mm.

#### **Electrostatic Discharge Caution**



This integrated circuit can be damaged by ESD.Bronze Technologies recommends that all integrated circuits be handled with appropriate precautions.Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure.Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.



## **11.2 Packing Information**



Note: 1) Legend unit: mm.

### **REEL DIMENSIONS**





ITEM FOOTPRII		
Reel Diameter	13 inches	
Reel Width(W1)	24mm	



## **12.Version Description**

REVISION	NOTES	DATE
Rev.0.0	Released datasheet	24-Nov-2023
Rev.0.1	Primary Side Supply Voltage Value, Primary Side Power Supply Voltage Value, Package Infographic Update	25-Jan-2024

## **IMPORTANT NOTICE AND DISCLAIMER**

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(1) selecting the appropriate bronze products for your application

(2) designing, validating and testing your application

(3) ensuring your application meets applicable standards.

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